IEC 62788-1-4

Edition 1.0 2016-09

INTERNATIONAL STANDARD

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Measurement procedures for materials used in photovoltaic modules – Part 1-4: Encapsulants – Measurement of optical transmittance and calculation of the solar-weighted photon transmittance, yellowness index, and UV cut-off wavelength

Procédures de mesure des matériaux utilisés dans les modules photovoltaïques – Partie 1-4: Encapsulants – Mesurage du facteur de transmission optique et calcul du facteur de transmission photonique à pondération solaire, de l'indice de jaunissement et de la fréquence de coupure des UV



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MEASUREMENT PROCEDURES FOR MATERIALS USED IN PHOTOVOLTAIC MODULES –

Part 1-4: Encapsulants – Measurement of optical transmittance and calculation of the solar-weighted photon transmittance, yellowness index, and UV cut-off wavelength

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International Standard IEC 62788-1-4 has been prepared by IEC technical committee 82: Solar photovoltaic energy systems.

The text of this standard is based on the following documents:

FDIS	Report on voting
82/1148/FDIS	82/1165/RVD

Full information on the voting for the approval of this standard can be found in the report on voting indicated in the above table.

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A list of all parts in the IEC 62788 series, published under the general title *Measurement procedures for materials used in photovoltaic modules*, can be found on the IEC website.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

The committee has decided that the contents of this publication will remain unchanged until the stability date indicated on the IEC website under "http://webstore.iec.ch" in the data related to the specific publication. At this date, the publication will be

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MEASUREMENT PROCEDURES FOR MATERIALS USED IN PHOTOVOLTAIC MODULES –

Part 1-4: Encapsulants – Measurement of optical transmittance and calculation of the solar-weighted photon transmittance, yellowness index, and UV cut-off wavelength

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1 Scope

This part of IEC 62788 provides a method for measurement of the optical transmittance of encapsulation materials used in photovoltaic (PV) modules. The standardized measurements in this procedure quantify the expected transmittance of the encapsulation to the PV cell. Subsequent calculation of solar-weighted transmittance allows for comparison between different materials. The results for unweathered material may be used in an encapsulation manufacturer's datasheets, in manufacturer's material or process development, in manufacturing quality control (material acceptance), or applied in the analysis of module performance.

This measurement method can also be used to monitor the performance of encapsulation materials after weathering, to help assess their durability. The standardized measurements are intended to examine an interior region within a PV module, e.g., without the effects of oxygen diffusion around the edges of the cells. Subsequent calculation of yellowness index allows for quantification of durability and consideration of appearance. The change in transmittance, yellowness index, and ultraviolet (UV) cut-off wavelength may be used by encapsulation or module manufacturers to compare the durability of different materials.

2 Normative references

The following documents are referred to in the text in such a way that some or all of their content constitutes requirements of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 60904-3, *Photovoltaic devices – Part 3: Measurement principles for terrestrial photovoltaic (PV) solar devices with reference spectral irradiance data*

ISO 291:2008, *Plastics – Standard atmospheres for conditioning and testing*

ISO 11664-1:2007, *Colorimetry – Part 1: CIE standard colorimetric observers*

ISO 11664-2:2007, *Colorimetry – Part 2: CIE standard illuminants*

ISO 13468-2:1999, *Plastics – Determination of the total luminous transmittance of transparent materials – Part 2: Double-beam instrument*

ISO 17223:2014, *Plastics – Determination of yellowness index and change in yellowness index*

ASTM E424-71:2007, *Standard test methods for solar energy transmittance and reflectance (Terrestrial) of sheet material*